

PYRGEOMETER CALIBRATION UNCERTAINTY

Ian Dollery

BSRN - 2016

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Challenge

- ▶ An uncertainty to meet the BSRN Longwave Target:
 - ▶ 5% or 10 W.m⁻² (1997)

Action

- ▶ Used Guide to the Expression of Uncertainty in Measurement (GUM) methods to develop the uncertainty

Result

- ▶ Uncertainty < target
- ▶ Highlighted major contributors (focused developments)

CALIBRATION METHODS

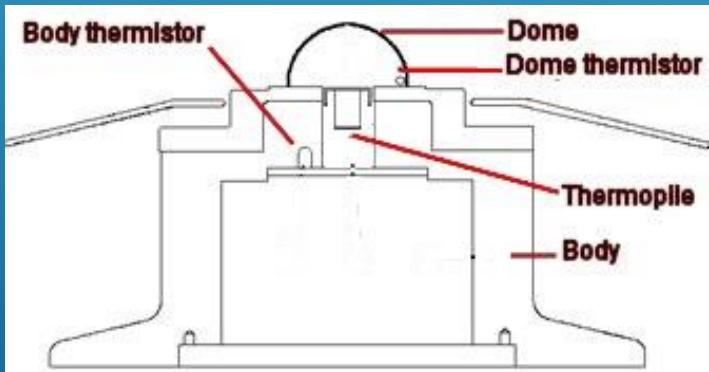


Black Body

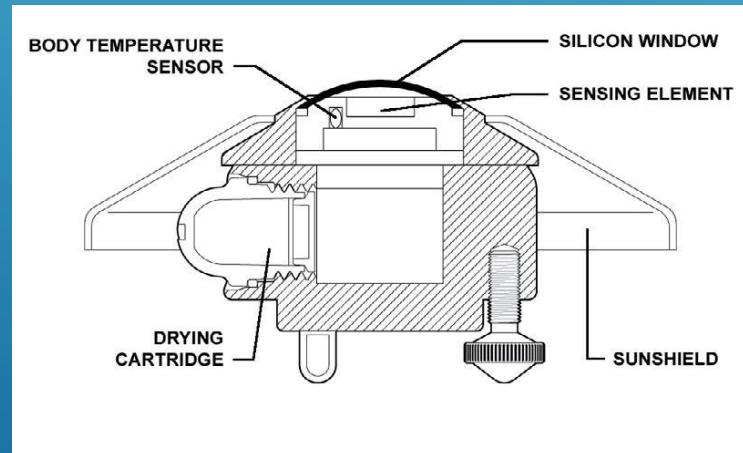


Comparison

PYRGEOMETERS



Eppley PIR



Kipp & Zonen CGR4

UNCERTAINTY DEVELOPMENT

Adapted from the GUM (Section 8)

1. Model (measureand) $f(x_1, x_2, \dots x_n)$
2. List inputs $x_1, x_2, \dots X_n$
3. input uncertainties $u(X_n);$
4. sensitivity coefficients $\frac{\delta f}{\delta X_n}$ or $\frac{\Delta f}{\Delta X_n}$
5. Convert into measurand uncertainties; $u(f(X_n)) = (\delta f / \delta X_n) * u(X_n)$
6. Combine uncertainties $u(f)^2 = \sum (f(X_n))^2$
7. Express as 95% uncertainty $U(f).$

MATHEMATICAL MODEL

$$C = \frac{V}{E_{L,REF} + K_S(E_D - E_B) - E_B}$$

Calibration Equation

$$E_L = \frac{V}{C} + E_B - K.(E_D - E_B)$$
$$E_D = \sigma.T_D^4$$

Field Equation

$$E_{L,REF} = \frac{V_{REF}}{C_{REF}} \left(1 + K_{1,REF} \cdot \sigma \cdot \frac{T_{B,REF}^4}{T_{B,REF}} \right) + K_{2,REF} \cdot E_{B,REF} - K_{3,REF} \cdot (E_{D,REF} - E_{B,REF})$$

PMOD Equation

ADDITIONAL INPUTS

$$E = \sigma \cdot T^4$$

$$T = \frac{1}{a + \beta \cdot \ln(R) + \gamma \cdot (\ln(R))^3}.$$

SENSITIVITY COEFFICIENTS

1. Unit conversion factor
2. The sensitivity of the measureand to changes in the input

Determined by either:

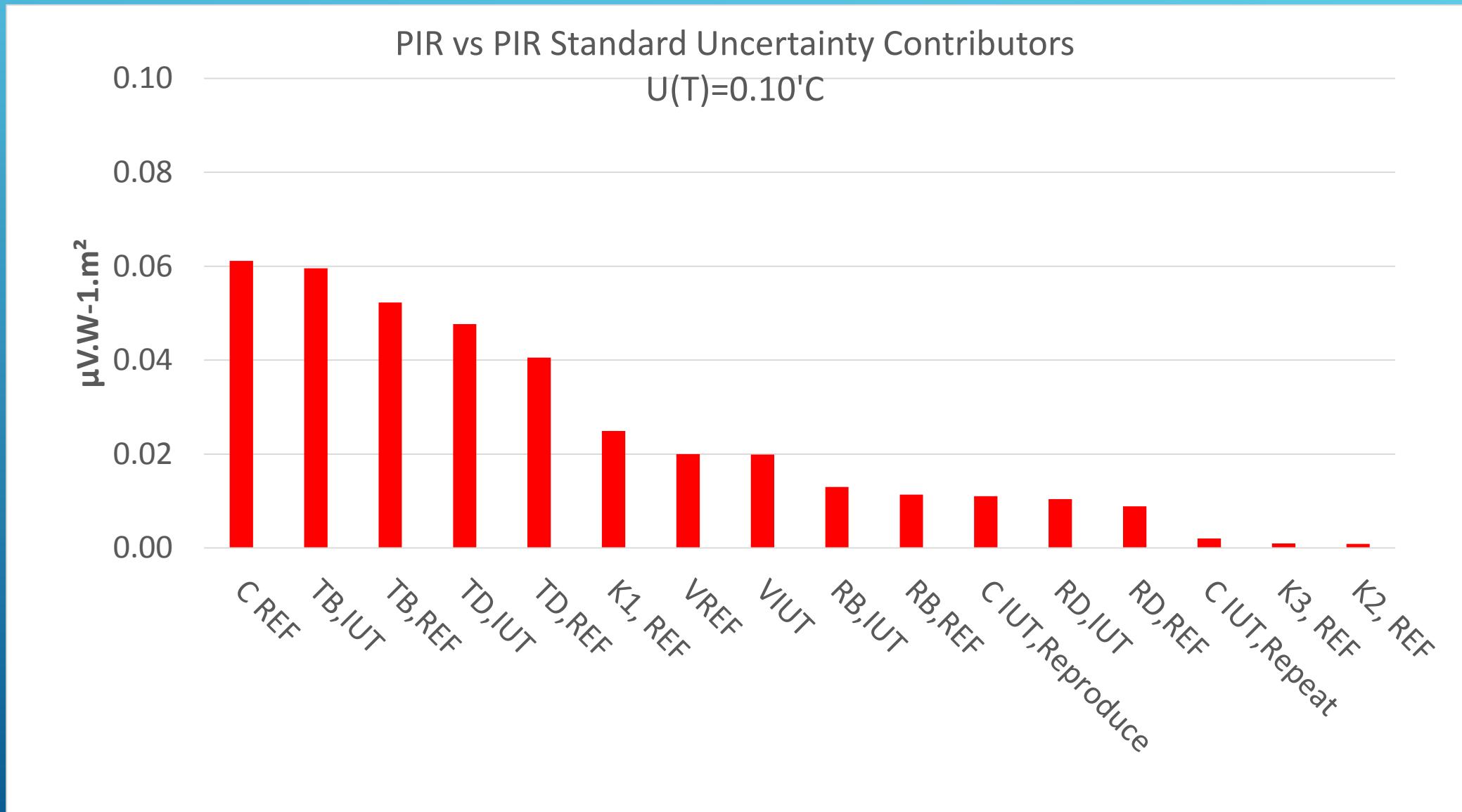
- Partial derivative of the model w.r.t. inputs; or
- Calculating the impact of small changes by inputs.

$$\frac{\delta f}{\delta X_n} \approx \frac{\Delta f}{\Delta X_n}$$

$$u(f) = \sqrt{\sum_i \left(\frac{\partial C_{IUT}}{\partial X_i} \cdot u(X_i) \right)^2}$$

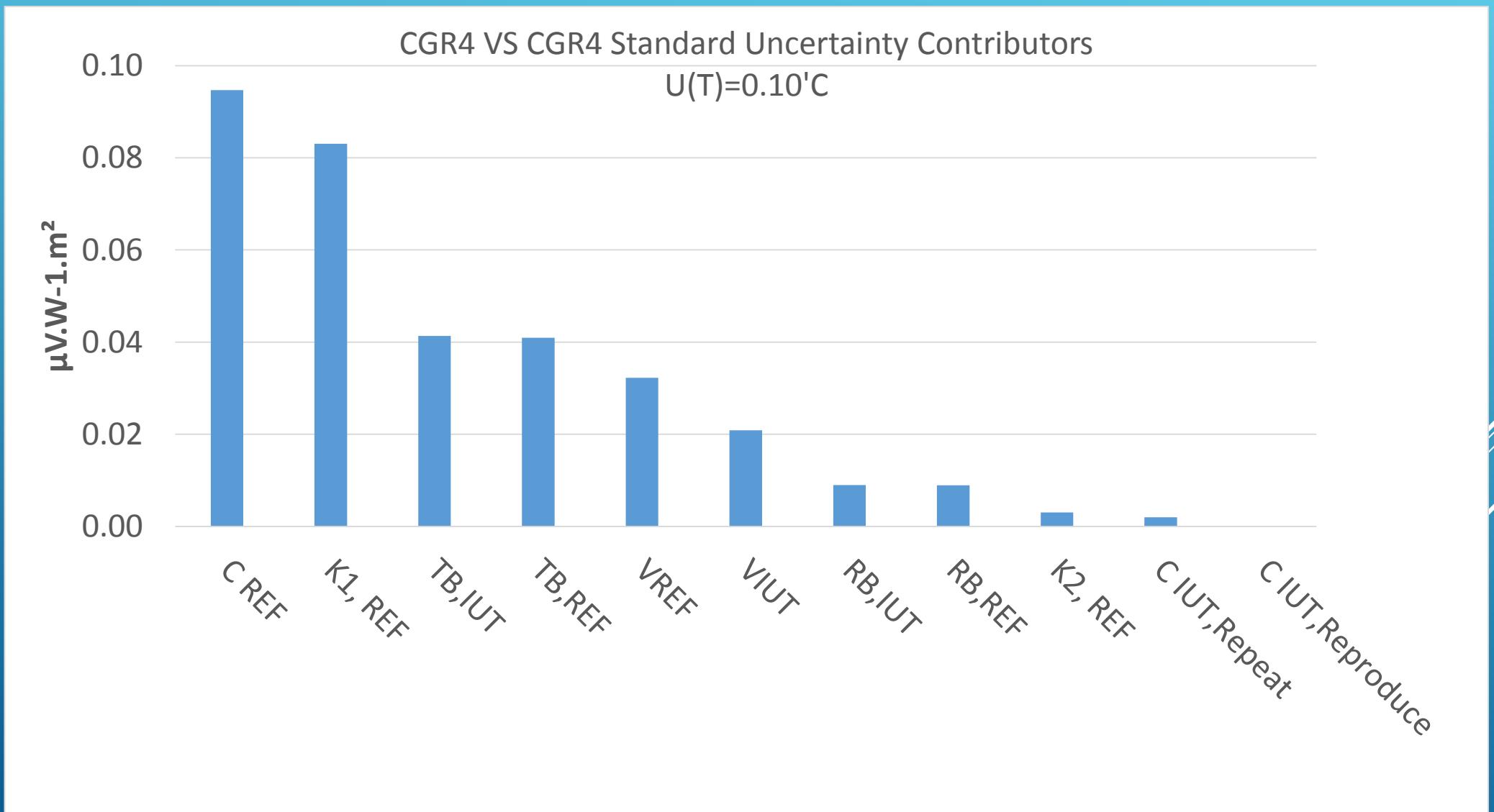
RELATIVE MAGNITUDE OF THE INPUTS

For a coefficient of $3.73 \text{ } \mu\text{V} \cdot \text{W}^{-1} \cdot \text{m}^2$ the uncertainty is $0.25 \text{ } \mu\text{V} \cdot \text{W}^{-1} \cdot \text{m}^2$ at a 95%

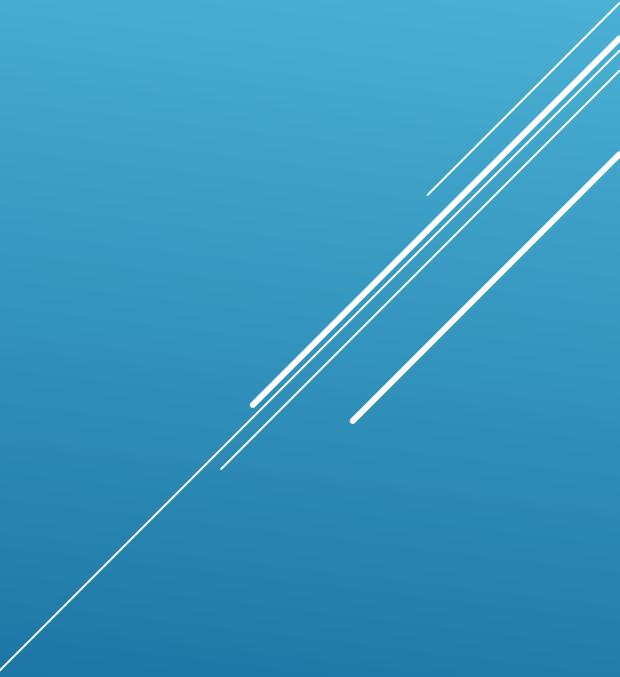


RELATIVE MAGNITUDE OF THE INPUTS

For a coefficient of $12.3 \mu\text{V}.\text{W}^{-1}.\text{m}^2$ the uncertainty is $0.28 \mu\text{V}.\text{W}^{-1}.\text{m}^2$ at a 95%

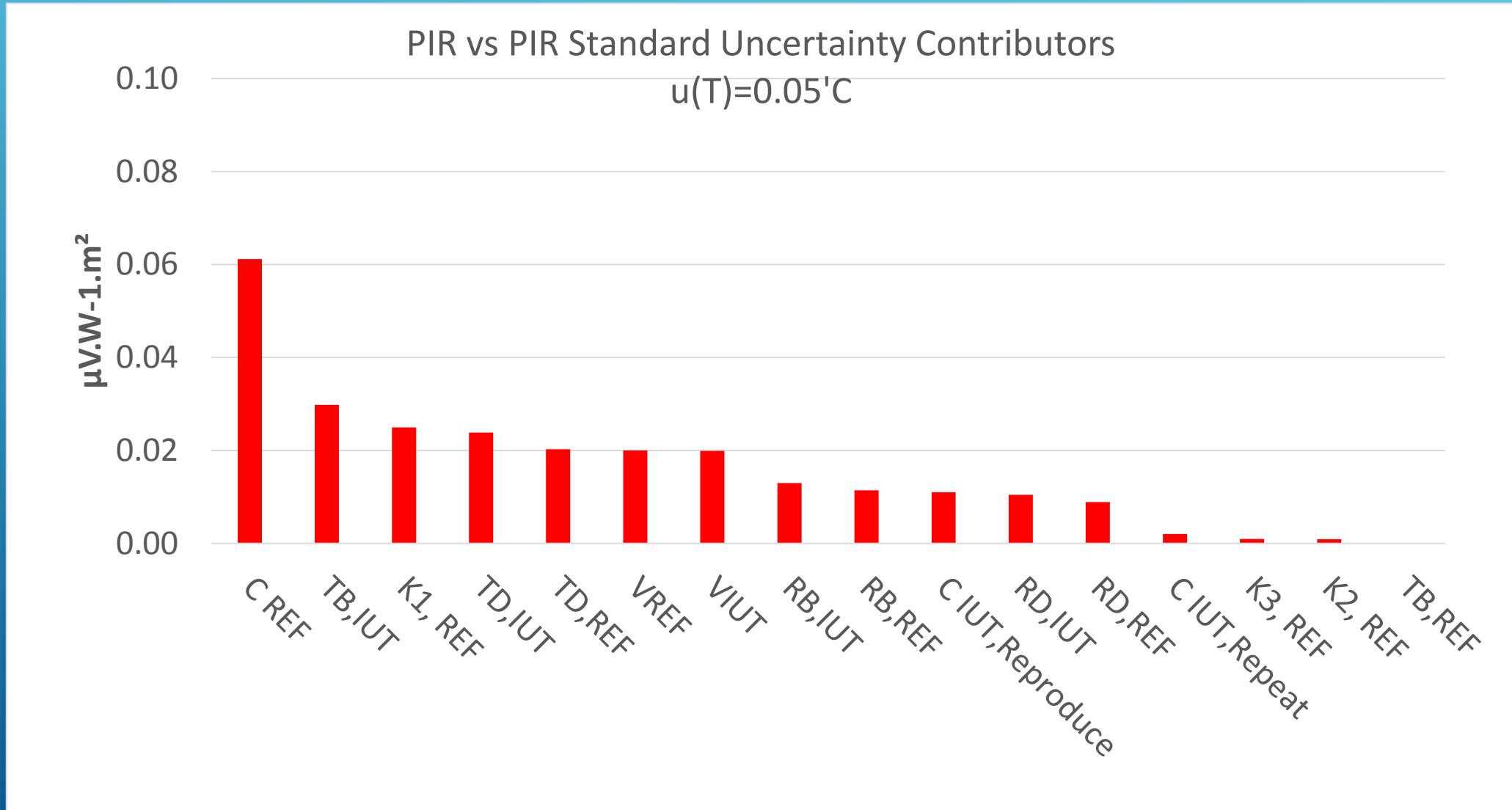


RETURN ON EFFORT UNCERTAINTY IMPROVEMENTS



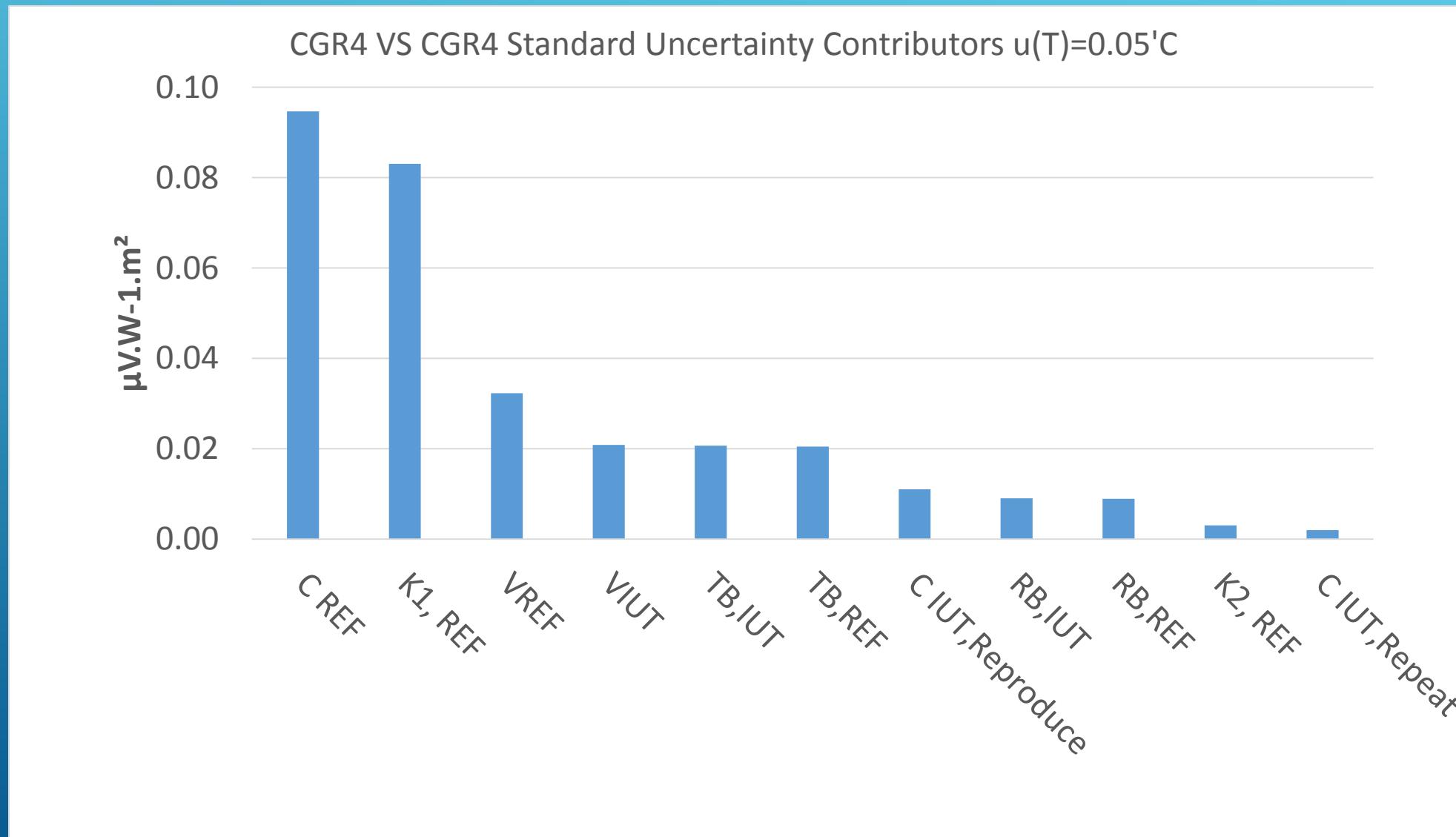
RELATIVE MAGNITUDE OF THE INPUTS

For a coefficient of $3.73 \text{ } \mu\text{V} \cdot \text{W}^{-1} \cdot \text{m}^2$ the uncertainty is $0.18 \text{ } \mu\text{V} \cdot \text{W}^{-1} \cdot \text{m}^2$ at a 95%



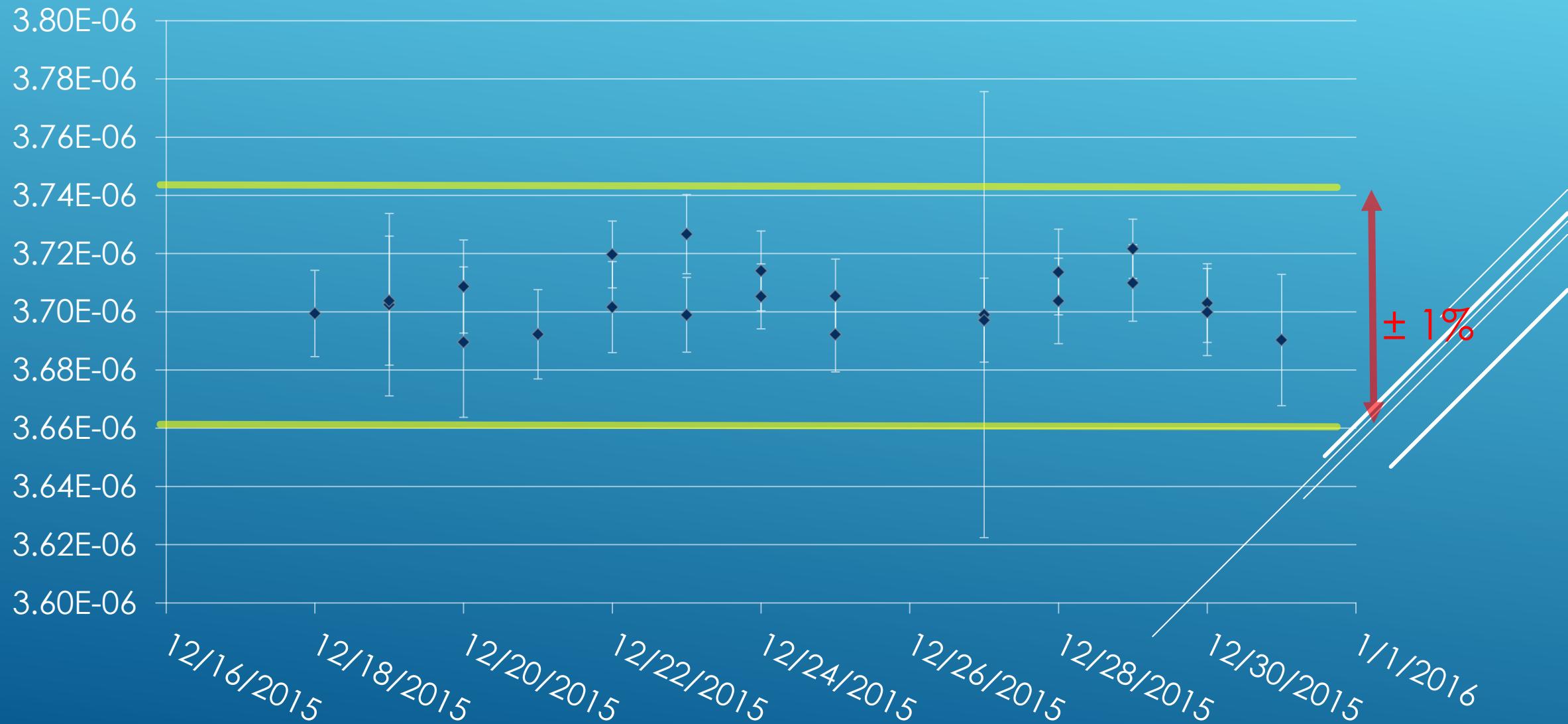
RELATIVE MAGNITUDE OF THE INPUTS

For a coefficient of $12.3 \mu\text{V}.\text{W}^{-1}.\text{m}^2$ the uncertainty is $0.26 \mu\text{V}.\text{W}^{-1}.\text{m}^2$ at a 95%



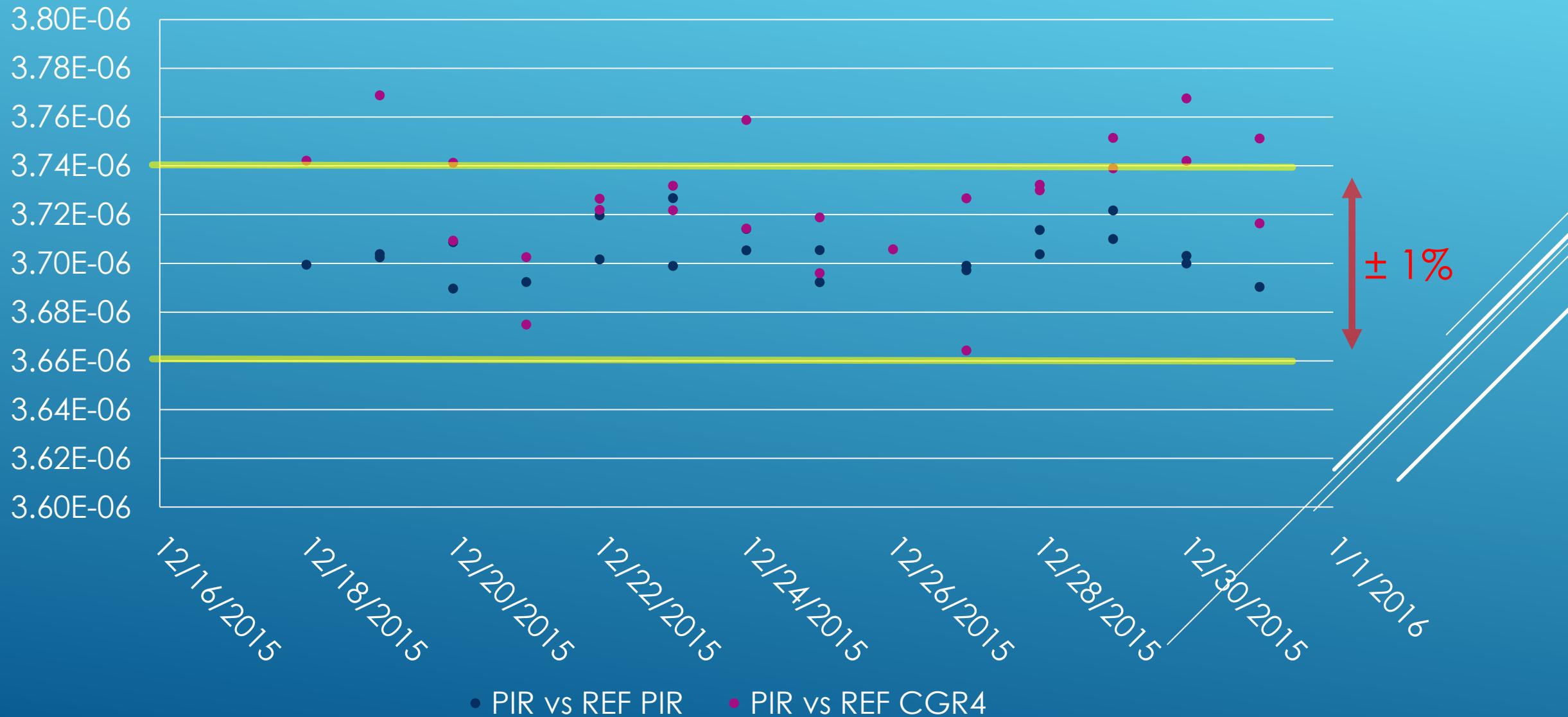
TEST DATA EXAMPLE (PIR VS PIR)

Daily Files Calculated V.W-1.m²



TEST DATA EXAMPLE (PIR VS CGR4)

PIR C vs Different Model References



Parameter	Value	Units	Standard Uncertainty (u)	Sensitivity Coefficient (W.m ⁻²)	Degrees of Freedom (Dof)	u.s (W.m ⁻²)
V _{REF}	-3.34E-04	V	1.78E-06	2.68E+05	12.5	0.48
R _{B,REF}	1.22E+04	Ω	5.5	-5.66E-02	12.5	-0.31
T _{B,REF}	293.27	K	0.050	-2.29E+01	26	-1.15
R _{D,REF}	1.22E+04	Ω	5.5	4.55E-02	12.5	0.25
T _{D,REF}	293.35	K	0.050	-2.29E+01	26	-1.15
C _{REF}	3.73E-06	V.W ⁻¹ .m ⁻²	1.26E-07	2.41E+07	92.77	3.04
K _{1, REF}	0	K ⁻¹				
K _{2, REF}	1	—				
K _{3, REF}	4	—				
						(W.m ⁻²)
E _{L,REF,CAL}	328.03	W.m ⁻²	—		141.85	3.50

Measurement uncertainty less than (5% or 10 W.m⁻²)

3.50 W.m⁻² in 328.03 W.m⁻² (~1%)

Major contributors

Thermistors temperature measurement

Uncertainty Incomplete

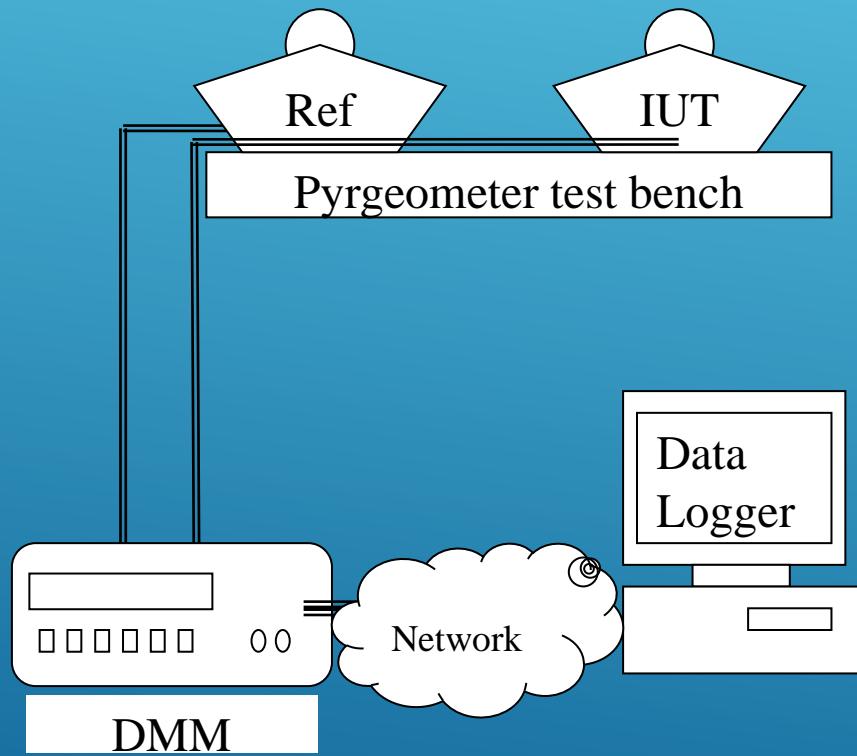
Small but insignificant difference between CGR4 and PIR

WHAT HAVE WE ACHIEVED?

QUESTIONS



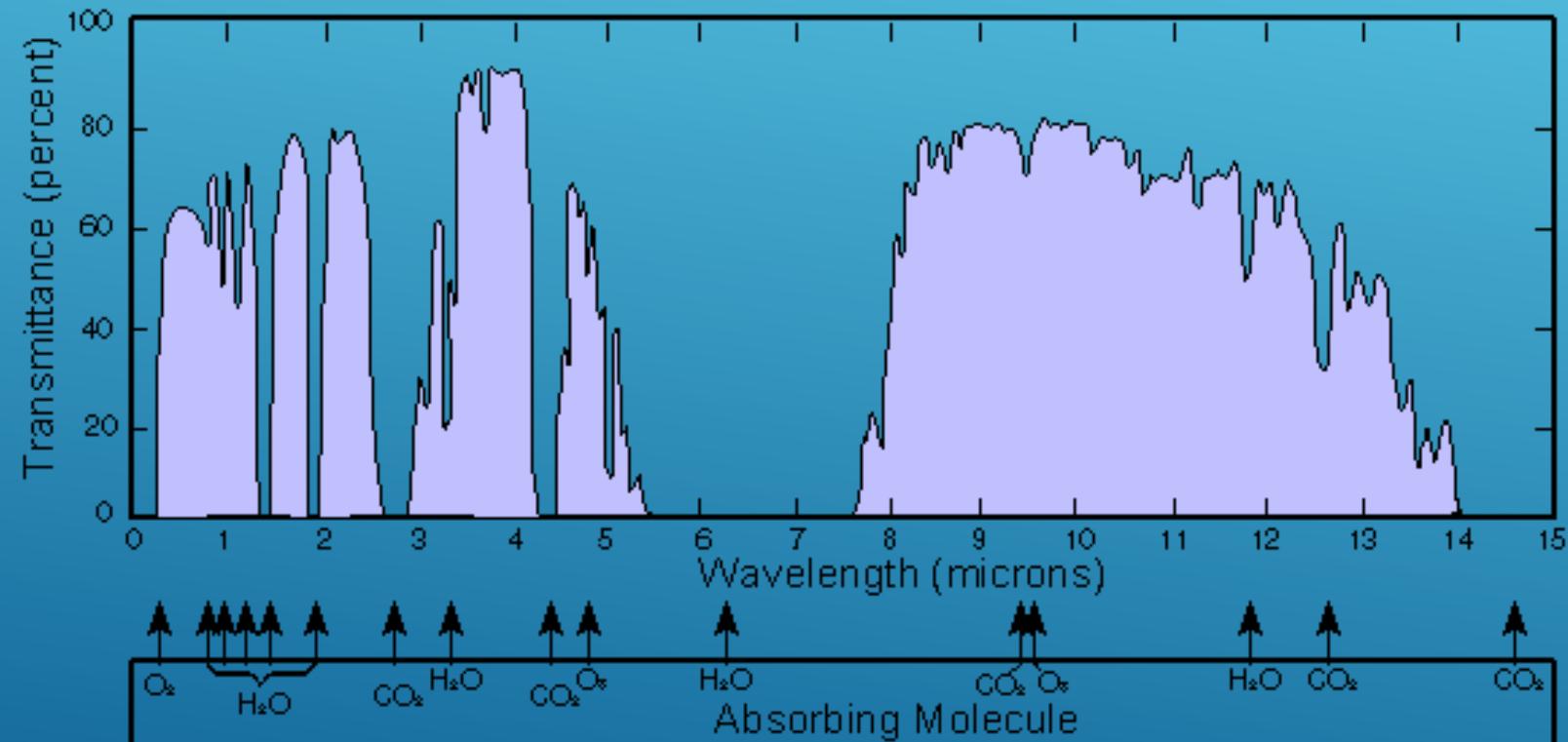
BUREAUS SKY COMPARISON TEST SYSTEM



REFERENCES

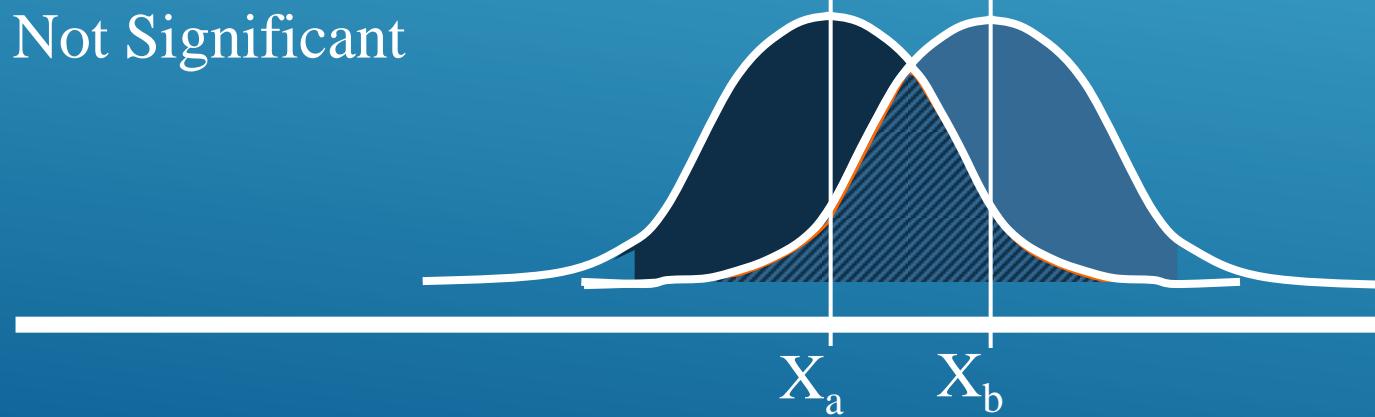
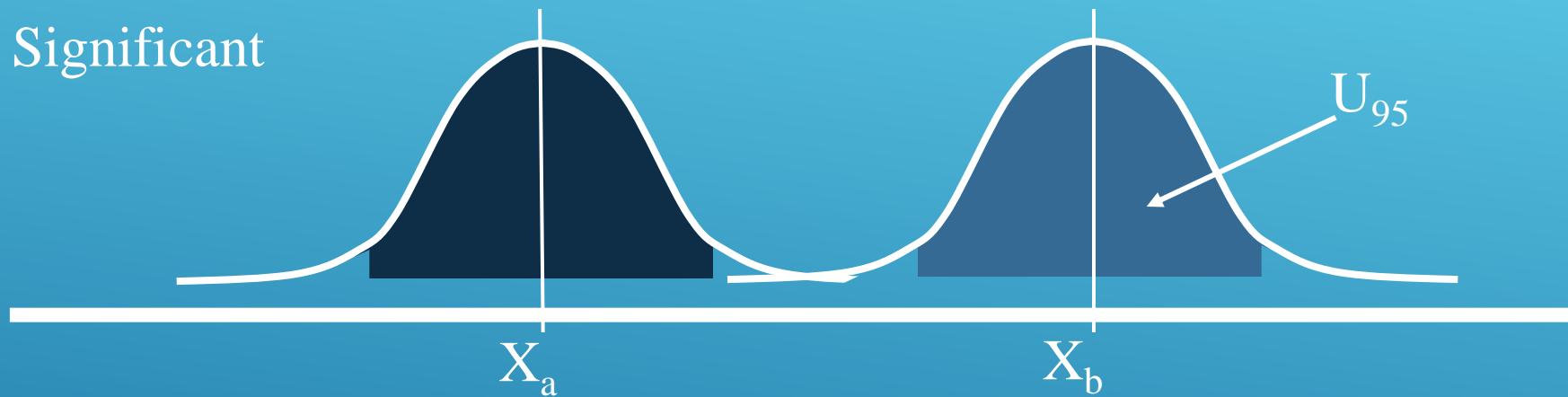
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ATMOSPHERIC WINDOW

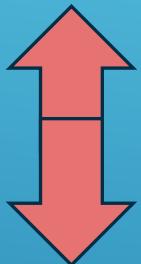


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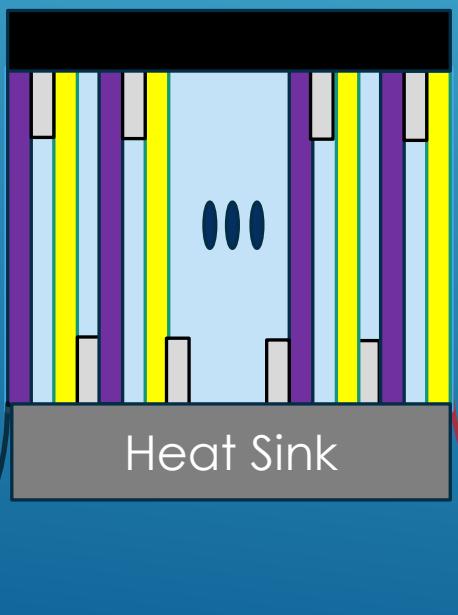
SIGNIFICANCE OF DIFFERENCES



THERMOPILE



Irradiance W/m²

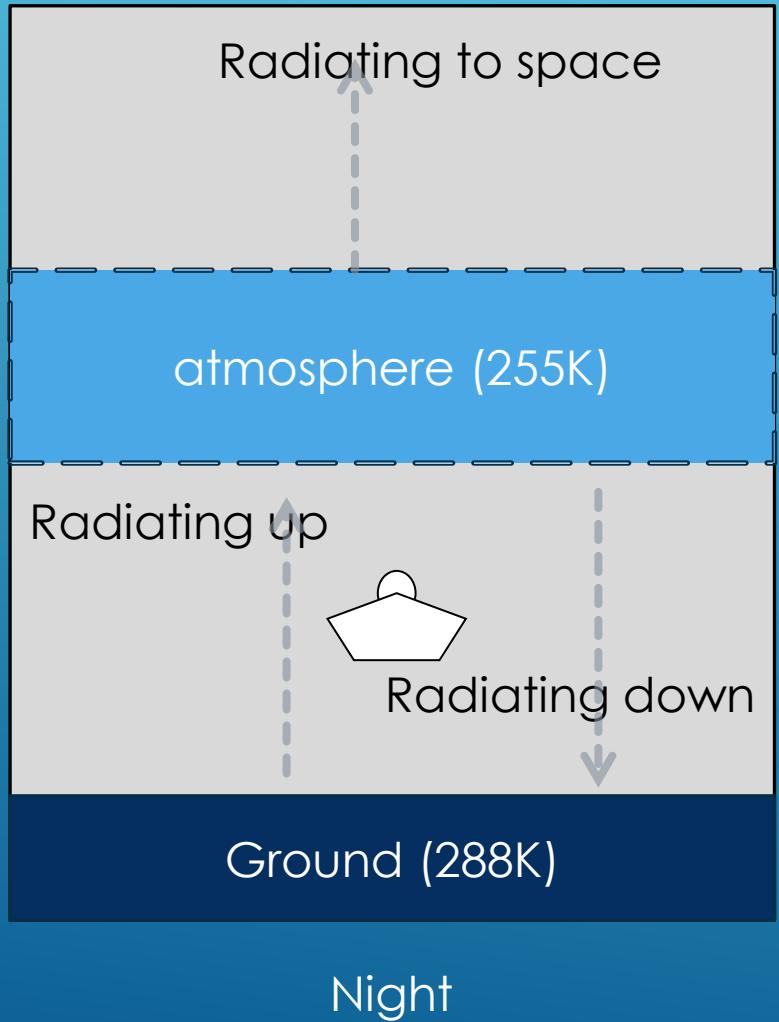


High Emissivity Surface T_1

Thermopile
Signal Volt = $S \times (T_1 - T_2)$

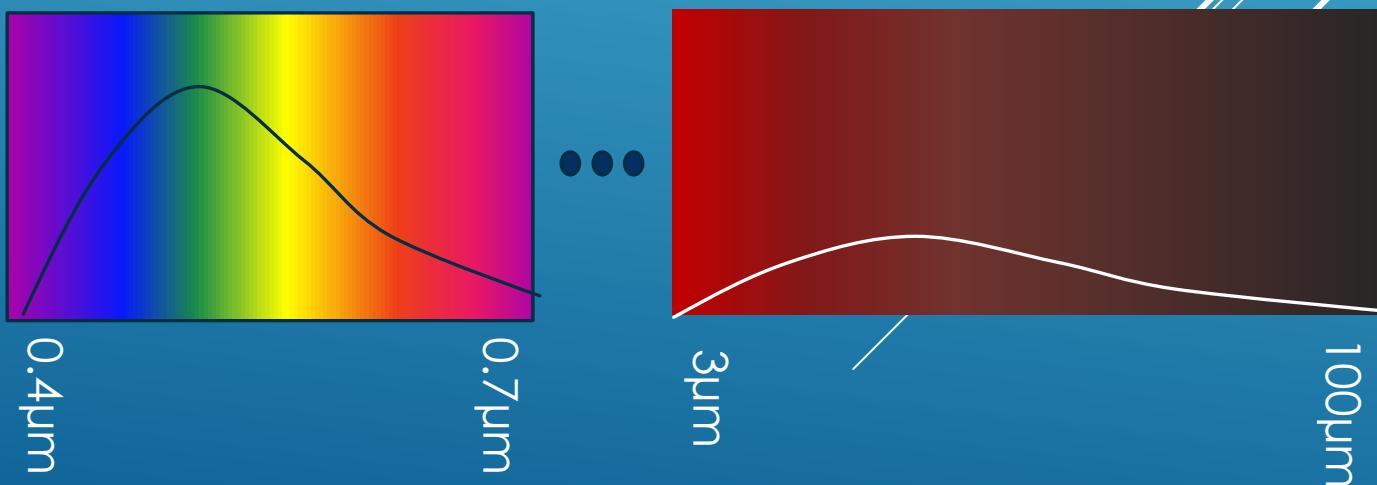
Body T_2

OVERVIEW LONGWAVE MEASUREMENT



Source	Effective BB Temperature	Wavelength maximum
Day (in)	5780 K (5507°C)	0.5 µm
Night (in)	255K (-18°C)	11µm
Terrestrial (out)	288K (15°C)	10µm

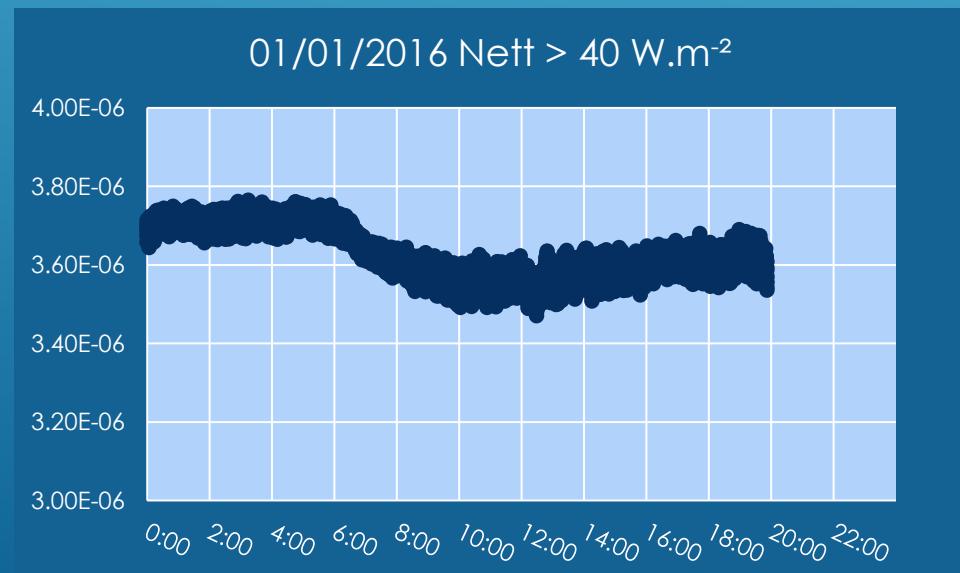
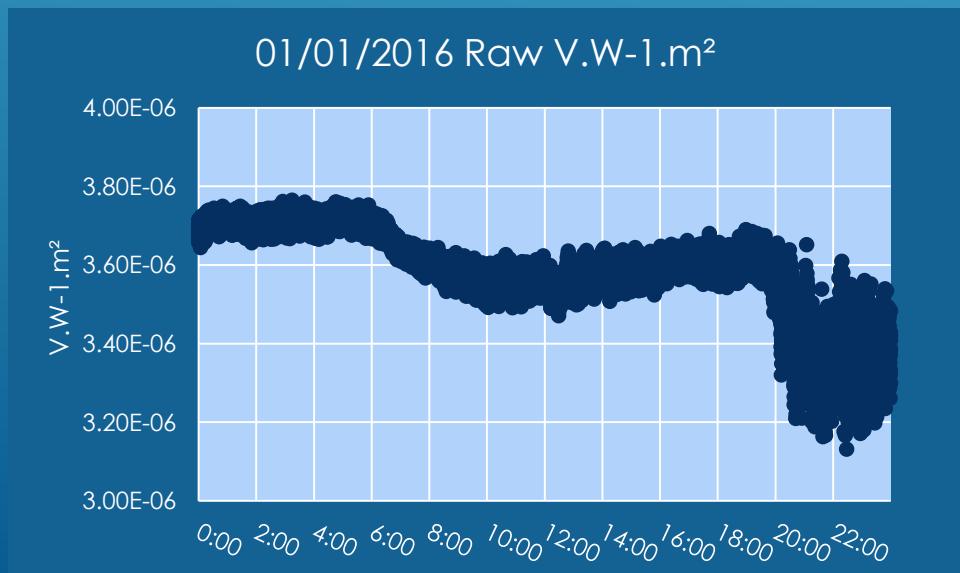
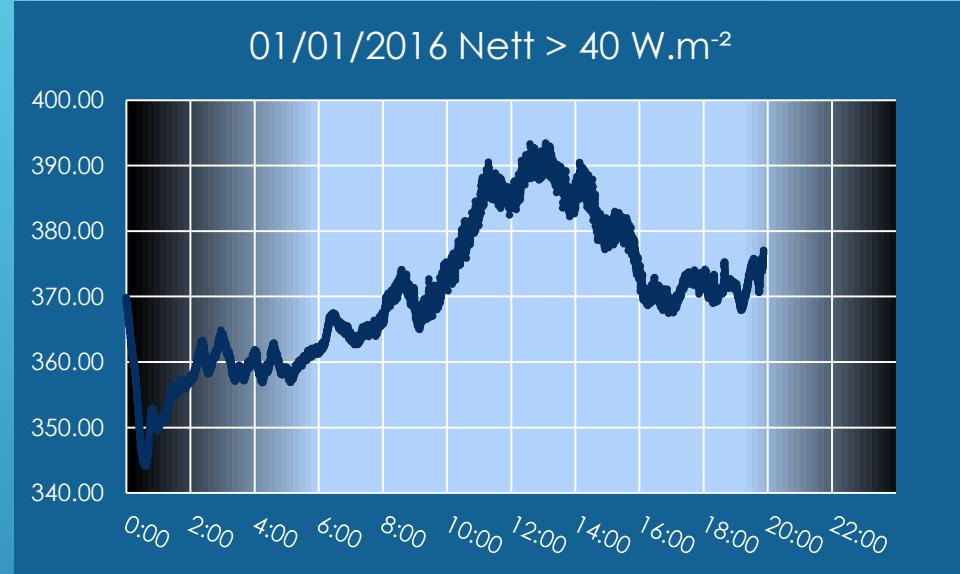
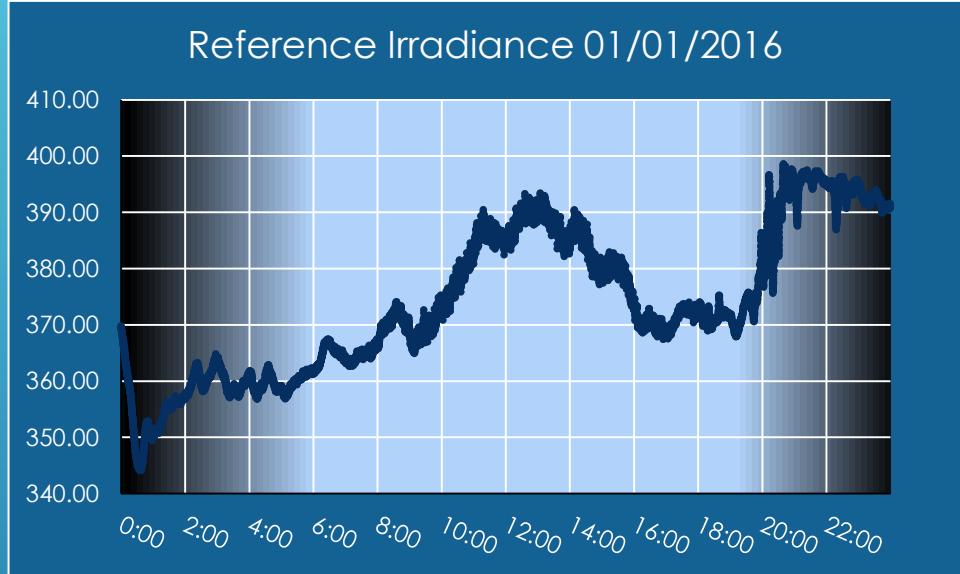
Recommended longwave uncertainty is:
5% or 10 W.m⁻² whichever is greater



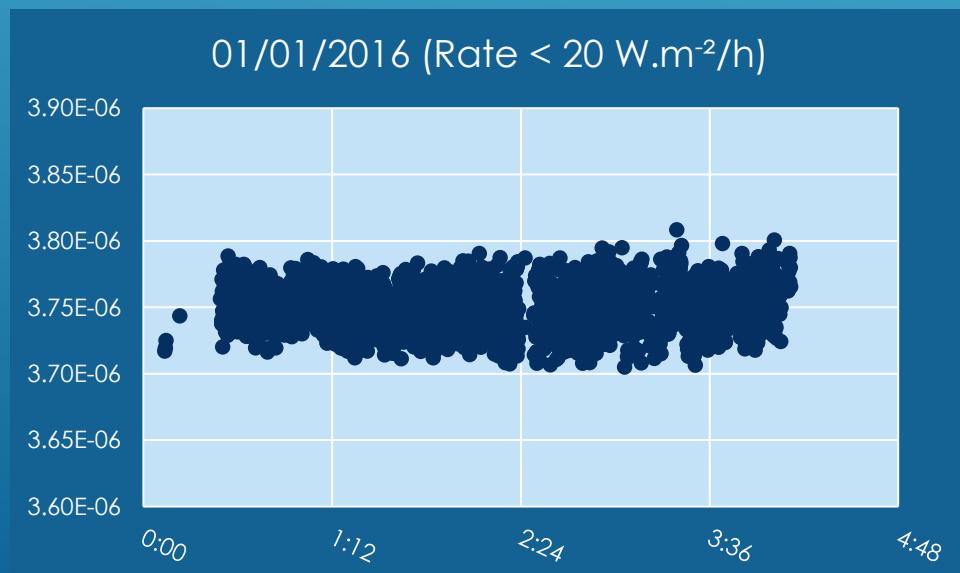
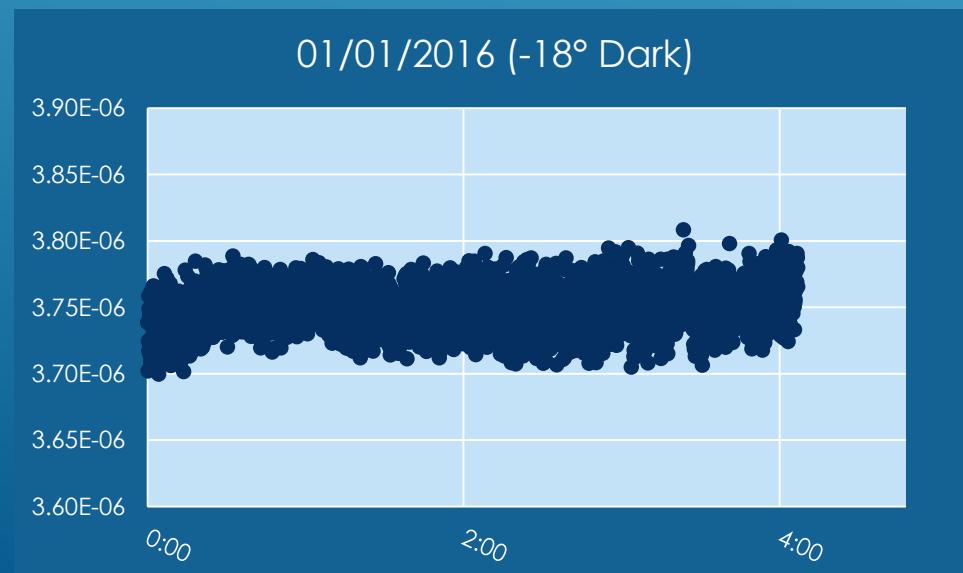
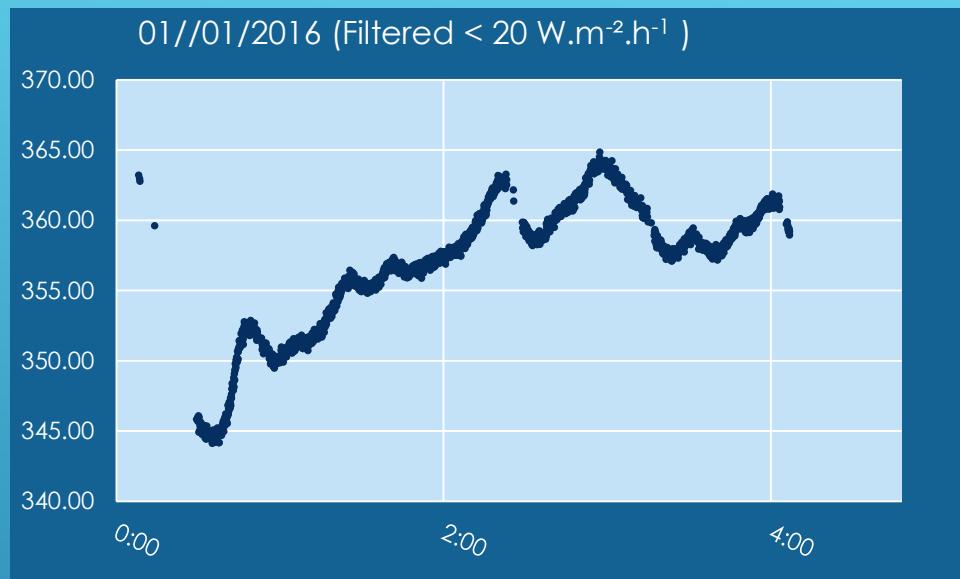
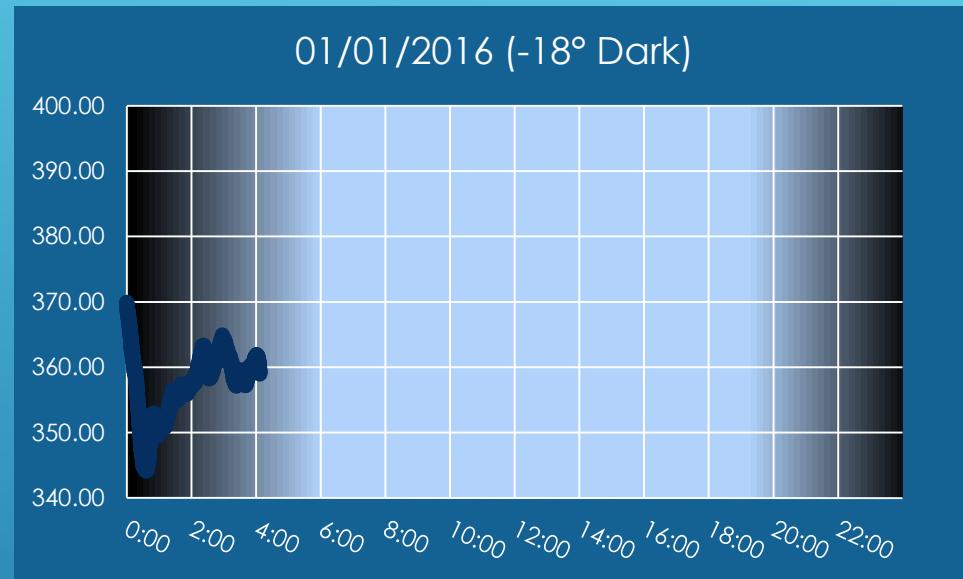
TEST METHOD

1. Mount the test and the reference pyrgeometer (same model);
2. Select data from astronomically (-18°) dark skies;
3. Calculate reference irradiance (PMOD calibration equation);
4. Filter for significant nett irradiance data ($>40 \text{ W.m}^{-2}$);
5. Filter for stable irradiance data ($<20 \text{ W.m}^{-2.h}^{-1}$);
6. Calculate pyrgeometer sensitivity coefficient (Field Equation);
7. Select nights (>4) with sensitivity coefficients with $\sigma < 2\%$.
8. Calculate the uncertainty;

TEST DATA EXAMPLE



TEST DATA EXAMPLE (PART 2)



SENSITIVITY COEFFICIENTS (REFERENCE E_L)

$$\frac{\partial E_{L,REF}}{\partial C_{REF}} = -\frac{V}{C_{REF}^2} \left(1 + K_1 \cdot \sigma \cdot T_{B,REF}^3 \right)$$

$$\frac{\partial E_{L,REF}}{\partial K_{1,REF}} = \frac{V}{C_{REF}} \sigma \cdot T_{B,REF}^3$$

$$\frac{\partial E_{L,REF}}{\partial K_{2,REF}} = -\sigma \cdot T_{B,REF}^4$$

$$\frac{\partial E_{L,REF}}{\partial K_{3,REF}} = \sigma \cdot (T_{B,REF}^4 - T_{D,REF}^4)$$

$$\frac{\partial E_{L,REF}}{\partial V_{REF}} = \frac{(1 + K_{1,REF} \cdot \sigma \cdot T_{B,REF}^3)}{C_{REF}}$$

$$\frac{\partial E_{L,REF}}{\partial T_{D,REF}} = -4 \cdot K_{3,REF} \cdot \sigma \cdot T_{D,REF}^3$$

$$\frac{\partial E_{L,REF}}{\partial T_{B,REF}} = 3 \cdot \frac{V_{REF}}{C_{REF}} \cdot K_{1,REF} \cdot \sigma \cdot T_{B,REF}^2 + 4 \cdot \sigma \cdot T_{B,REF}^3 \cdot (K_{2,REF} + K_{3,REF})$$

$$\frac{\partial E_{L,REF}}{\partial R_{B,REF}} = \frac{\partial E_{L,REF}}{\partial T_{B,REF}} \cdot \frac{\partial T_{B,REF}}{\partial R_{B,REF}}$$

$$\frac{\partial T_{B,REF}}{\partial R_{B,REF}} = \frac{-\beta - 3 \cdot \gamma \cdot \ln(R_{B,REF})^2}{R_{B,REF} \cdot (\alpha + \beta \cdot \ln(R_{B,REF}) + \gamma \cdot \ln(R_{B,REF})^3)^2}$$

$$\frac{\partial E_{L,REF}}{\partial R_{D,REF}} = \frac{\partial E_{L,REF}}{\partial T_{D,REF}} \cdot \frac{\partial T_{D,REF}}{\partial R_{D,REF}}$$

$$\frac{\partial T_{D,REF}}{\partial R_{D,REF}} = \frac{-\beta - 3 \cdot \gamma \cdot \ln(R_{D,REF})^2}{R_{D,REF} \cdot (\alpha + \beta \cdot \ln(R_{D,REF}) + \gamma \cdot \ln(R_{D,REF})^3)^2}$$

REFERENCE IRRADIANCE UNCERTAINTY

$$u(E_{L,REF})^2 = \left(\frac{\partial E_{L,REF}}{\partial C_{REF}} \cdot u(C_{REF}) \right)^2 + \left(\frac{\partial E_{L,REF}}{\partial K_{1,REF}} \cdot u(K_{1,REF}) \right)^2 + \left(\frac{\partial E_{L,REF}}{\partial K_{2,REF}} \cdot u(K_{2,REF}) \right)^2 + \left(\frac{\partial E_{L,REF}}{\partial K_{3,REF}} \cdot u(K_{3,REF}) \right)^2 + \left(\frac{\partial E_{L,REF}}{\partial V_{REF}} \cdot u(V_{REF}) \right)^2 + \left(\frac{\partial E_{L,REF}}{\partial T_{B,REF}} \cdot u(T_{B,REF}) \right)^2 + \left(\frac{\partial E_{L,REF}}{\partial R_{B,REF}} \cdot u(R_{B,REF}) \right)^2 + \left(\frac{\partial E_{L,REF}}{\partial T_{D,REF}} \cdot u(T_{D,REF}) \right)^2 + \left(\frac{\partial E_{L,REF}}{\partial R_{D,REF}} \cdot u(R_{D,REF}) \right)^2$$

SENSITIVITY COEFFICIENTS (IUT)

$$\frac{\partial C_{IUT}}{\partial E_{L,REF}} = \frac{-V}{E_{nett}^2}$$

$$E_{nett} = E_{L,REF} + K_s \cdot \sigma \cdot (T_{D,IUT}^4 - T_{B,IUT}^4) - \sigma \cdot T_{B,IUT}^4$$

$$\frac{\partial C_{IUT}}{\partial V_{IUT}} = \frac{1}{E_{nett}}$$

$$\frac{\partial C_{IUT}}{\partial R_{B,IUT}} = \frac{\partial C_{IUT}}{\partial T_{B,IUT}} \cdot \frac{\partial T_{B,IUT}}{\partial R_{B,IUT}}$$

$$\frac{\partial C_{IUT}}{\partial T_{B,IUT}} = \frac{V \cdot 4 \cdot \sigma \cdot T_{B,IUT}^3 \cdot (K_s + 1)}{E_{nett}^2}$$

$$\frac{\partial T_{B,IUT}}{\partial R_{B,IUT}} = \frac{-\beta - 3\gamma \cdot \ln(R_{B,IUT})^2}{R_{B,IUT} \cdot (\alpha + \beta \cdot \ln(R_{B,IUT}) + \gamma \cdot \ln(R_{B,IUT})^3)^2}$$

$$\frac{\partial C_{IUT}}{\partial T_{B,IUT}} = \frac{V_{IUT} \cdot 4 \cdot \sigma \cdot T_{B,IUT}^3 \cdot (1 + K_{s,IUT})}{E_{nett}^2}$$

$$\frac{\partial C_{IUT}}{\partial R_{D,IUT}} = \frac{\partial C_{IUT}}{\partial T_{D,IUT}} \cdot \frac{\partial T_{D,IUT}}{\partial R_{D,IUT}}$$

$$\frac{\partial C_{IUT}}{\partial T_{D,IUT}} = \frac{V_{IUT} \cdot K_{s,IUT} \cdot 4 \cdot \sigma \cdot T_{D,IUT}^3}{E_{nett}^2}$$

$$\frac{\partial T_{D,IUT}}{\partial R_{D,IUT}} = \frac{-\beta - 3\gamma \cdot \ln(R_{D,IUT})^2}{R_{D,IUT} \cdot (\alpha + \beta \cdot \ln(R_{D,IUT}) + \gamma \cdot \ln(R_{D,IUT})^3)^2}$$

$$\frac{\partial C_{IUT}}{\partial T_{D,IUT}} = \frac{V_{IUT} \cdot K_{s,IUT} \cdot 4 \cdot \sigma \cdot T_{D,IUT}^3}{E_{nett}^2}$$

$$\frac{\partial C_{IUT}}{\partial C_{IUT}} = 1$$

$$\frac{\partial C_{IUT}}{\partial C_{IUT}} = 1$$

STEP 4. ATTRIBUTING STANDARD UNCERTAINTIES

- ▶ The two major evaluation categories are:
 - ▶ Type A - by statistical methods
 - ▶ Type B - by other means:

Purpose: to quantify a standard uncertainty

EXAMPLE: $U(R_B)$ UNCERTAINTY IN DMM MEASUREMENT OF BASE THERMISTOR RESISTANCE

YSI 44031 (-10°C to +55 °C) 50 kΩ to 5 kΩ

Type A: laboratory testing over a year

- ▶ Measure standard resistors with DMM in likely ambient conditions (climate chamber)
- ▶ From scatter of residuals determine
 - ▶ Standard uncertainty (SD) and DOF

EXAMPLE: $U(R_B)$ UNCERTAINTY IN DMM MEASUREMENT OF BASE THERMISTOR

- ▶ YSI 44031 (-10°C to +55 °C) 50 kΩ to 5 kΩ
- ▶ Type B: Manufacture Specifications
 - ▶ The DMM specification
 - ▶ 100 ppm of reading + 10 ppm of range (95%)
(over a 1 year calibration interval)
 - ▶ Expanded $U=11\Omega$ for the range 50 kΩ to 5 kΩ (95%)
 - ▶ $\text{Std } u = 5.5 \Omega$
(assuming $cf = 2.0$ for a normal distribution)

INPUTS UNCERTAINTIES

- $u(EL,REF)$ Reference Irradiance, (C, K1, K2, K3 and PMOD Equation).
- $u(VREF)$ Ref thermopile voltage by the DMM.
- $u(TB,REF)$ Ref base temperature (manufacturing tolerance).
- $u(TD,REF)$ Ref dome temperature (manufacturing tolerance).
- $u(RB,REF)$ Ref base temperature (DMM resistance measurement).
- $u(RD,REF)$ Ref dome temperature (DMM resistance measurement).
- $u(VIUT)$ IUT thermopile voltage by the DMM.
- $u(TB,IUT)$ IUT base temperature (manufacturing tolerance).
- $u(TD,IUT)$ IUT dome temperature (manufacturing tolerances).
- $u(RB,IUT)$ IUT base temperature (DMM resistance measurement).
- $u(RD,IUT)$ IUT dome temperature (DMM resistance measurement)
- $u(CRepeat, IUT)$ Maximum ESDOM in C from a single night.
- $u(CRepro, IUT)$ ESDOM for combined nightly average.

STEP 2. INPUTS

Reference

1. Reference Irradiance EL_{ref}
2. Reference calibration Coefficients (C_{ref} ,
 $K1_{ref}$, $K2_{ref}$, $K3_{ref}$)
3. Temperatures base and dome (Tb_{ref} , Td_{ref})
4. Performance of the temperature sensors
5. Measurement of the sensors resistance
6. Measurement of differential sky to earth (V_{ref})

Instrument under test

1. Temperatures base and dome (Tb_{IUT} , Td_{IUT})
2. Performance of the temperature sensors
3. Measurement of the sensors resistance
4. Measurement of differential sky to earth (V_{IUT})
5. Stability of the comparison sky
6. Reproducibility of the comparison

TRACEABILITY

- ▶ PMOD to
Bureau reference PIR and CGR4
- ▶ Bureau reference to
Transfer Standards and
new network instruments
- ▶ Transfer Standards to
Network instruments



References
under development